

# Frontiers of Surface Sensitive Electron Microscopy

*Surface Science Symposium*

*DPG Frühjahrstagung • February 25<sup>th</sup>-29<sup>th</sup>, 2008 • Berlin*

## *Confirmed Speakers*

*J. Hannon (IBM Yorktown Heights, USA)*

*J. Kirschner (MPI Halle, Germany)*

*C.M. Schneider (FZ Jülich, Germany)*

*R. van Gastel (Twente University, The Netherlands)*

*Th. Schmidt (Universität Würzburg, Germany)*

*L. Chelaru (FZ Jülich, Germany)*

## *Contact:*

*Frank-J. Meyer zu Heringdorf, Universität Duisburg-Essen ([meyerzh@uni-due.de](mailto:meyerzh@uni-due.de))*

*Gerd Schönhense, Universität Mainz ([schoenhe@uni-mainz.de](mailto:schoenhe@uni-mainz.de))*